



BGA8U1BN6

Low Noise Amplifier for Ultra High Band 4-6GHz (f.e. LTE - U/ LAA with bypass)

Features

- Operating frequencies: 4.0 6.0 GHz
- Insertion power gain: 13.7 dB
- Insertion Loss in bypass mode: 7.5 dB
- Low noise figure: 1.6 dB
- Low current consumption: 4.5 mA
- Multi-state control: OFF-, bypass- and high gain-Mode
- Ultra small TSNP-6-2 leadless package
- RF input and RF output internally matched to 50 Ohm, no external components necessary



Application

The LTE data rate can be significantly improved by using the Low Noise Amplifier. The integrated bypass function increases the overall system dynamic range and leads to more flexibility in the RF front-end.

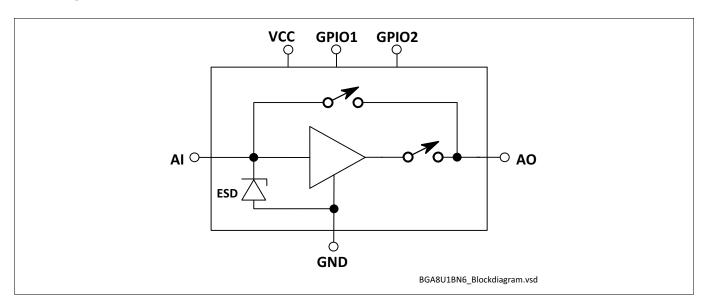
In high gain mode the LNA offers best Noise Figure to ensure high data rates even on the LTE cell edge. Closer to the basestation the bypass mode can be activated reducing current consumption.

The BGA8U1BN6 is designed for the inlicensed LTE spectrum (4-6GHz) part of the 3GPP Release 13.

Product Validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Block diagram



BGA8U1BN6 Low Noise Amplifier for Ultra High Band 4-6GHz (f.e. LTE - U/ LAA with bypass)

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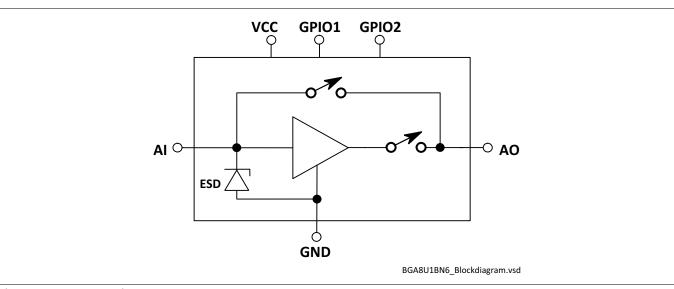
Features

RoHS

1 Features

- Insertion power gain: 13.7 dB
- Insertion Loss in bypass mode: 7.5 dB
- Low noise figure: 1.6 dB
- Low current consumption: 4.5 mA
- Operating frequencies: 4.0 6.0 GHz
- Multi-state control: OFF-, bypass- and high gain-Mode
- Supply voltage: 1.6 V to 3.1 V
- Ultra small TSNP-6-2 leadless package (footprint: 0.7 x 1.1 mm²)
- B9HF Silicon Germanium technology
- RF input and RF output internally matched to 50 Ohm
- No external SMD components necessary
- 2kV HBM ESD protection (including AI-pin)
- Pb-free (RoHS compliant) package







| Product Name | Marking | Package | |
|--------------|---------|----------|--|
| BGA8U1BN6 | Y | TSNP-6-2 | |

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Features

Description

The BGA8U1BN6 is a front-end low noise amplifier for LTE which covers a wide frequency range from 4.0 GHz to 6.0 GHz. The LNA provides 13.7 dB gain and 1.6 dB noise figure at a current consumption of 4.5 mA in the application configuration described in **Chapter 4**. In bypass mode the LNA provides an insertion loss of 7.5 dB. The BGA8U1BN6 is based upon Infineon Technologies' B7HF Silicon Germanium technology. It operates from 1.6 V to 3.1 V supply voltage. The device features a multi-state control (OFF-, bypass- and high gain-Mode).

Pin Definition and Function

| Table 1 Pin Definition and Function | | | | | | |
|-------------------------------------|-------|---------------|--|--|--|--|
| Pin No. | Name | Function | | | | |
| 1 | GPIO2 | Control pin 2 | | | | |
| 2 | VCC | DC supply | | | | |
| 3 | AO | LNA output | | | | |
| 4 | GPI01 | Control pin 1 | | | | |
| 5 | GND | Ground | | | | |
| 6 | AI | LNA input | | | | |

Control Table

Table 2Control Table

| | GPIO1 | GPIO2 |
|----------------|-------|-------|
| OFF | Low | Low |
| | High | Low |
| Bypass mode | Low | High |
| High gain mode | High | High |



Maximum Ratings

2 Maximum Ratings

Table 3Maximum Ratings

| Parameter | Symbol | | Value | Unit | Note or | |
|--|----------------------|-------|-------|-----------------------|---------|------------------------|
| | | Min. | Тур. | Max. | | Test Condition |
| Voltage at pin VCC | V _{cc} | -0.3 | _ | 3.6 | V | 1) |
| Voltage at pin Al | V _{AI} | -0.3 | - | 0.9 | V | - |
| Voltage at pin AO | V _{AO} | -0.3 | _ | V _{CC} + 0.3 | V | - |
| Voltage at GPIO pins | V _{GPIO} | -0.3 | - | V _{CC} + 0.3 | V | - |
| Voltage at pin GND | V _{GND} | -0.3 | - | 0.3 | V | - |
| Current into pin VCC | I _{cc} | - | _ | 16 | mA | - |
| RF input power | P _{IN} | - | - | +25 | dBm | - |
| Total power dissipation, $T_{\rm S} < 148 ^{\circ}{\rm C}^{2)}$ | P _{tot} | - | - | 60 | mW | - |
| Junction temperature | T | - | - | 150 | °C | - |
| Ambient temperature range | T _A | -40 | - | 85 | °C | - |
| Storage temperature range | T _{STG} | -65 | - | 150 | °C | - |
| ESD capability all pins | V _{ESD_HBM} | -2000 | - | +2000 | V | according to JS-001 |

1) All voltages refer to GND-Node unless otherwise noted

2) $T_{\rm S}$ is measured on the ground lead at the soldering point

Attention: Stresses above the max. values listed here may cause permanent damage to the device. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Exposure to conditions at or below absolute maximum rating but above the specified maximum operation conditions may affect device reliability and life time. Functionality of the device might not be given under these conditions.



Electrical Characteristics

3 Electrical Characteristics

Table 4Electrical Characteristics1)

 $T_{\rm A} = 25 \text{ °C}, V_{\rm CC} = 1.8 \text{ V}, V_{\rm GPIOX,ON} = 1.8 \text{ V}, V_{\rm GPIOX,OFF} = 0 \text{ V}, f = 4000 - 6000 \text{ MHz}$

| Parameter | Symbol | Values | | | Unit | Note or Test Condition |
|---|--------------------------------|--------|------|-----------------|------|--|
| | | Min. | Тур. | Max. | | |
| Supply voltage | V _{cc} | 1.6 | 1.8 | 3.1 | V | - |
| Control voltages | <i>V</i> _{GPIOx} | 1.0 | - | V _{cc} | V | High |
| | | 0 | - | 0.4 | V | Low |
| Supply current | I _{cc} | - | 4.3 | 5.3 | mA | High gain mode |
| | | - | 85 | 120 | μΑ | Bypass mode |
| | | - | 0.1 | 2 | μΑ | OFF-Mode |
| Insertion power gain | S ₂₁ ² | 10.9 | 13.4 | 15.9 | dB | High gain mode |
| f = 5500 MHz | | -9.5 | -7.5 | -5.5 | dB | Bypass mode |
| Noise figure ²⁾ | NF | - | 1.65 | 2.55 | dB | High gain mode |
| f = 5500 MHz, $Z_{\rm S}$ = 50 Ω | | - | 7.5 | 9.5 | dB | Bypass mode |
| Input return loss ³⁾ | RL _{IN} | 9 | 13 | - | dB | High gain mode |
| f = 5500 MHz | | 7 | 11 | - | dB | Bypass mode |
| Output return loss ³⁾ | RL _{OUT} | 12 | 20 | - | dB | High gain mode |
| f=5500 MHz | | 3 | 4 | - | dB | Bypass mode |
| Reverse isolation ³⁾ | $1/ S_{12} ^2$ | 20 | 28 | - | dB | High gain mode |
| f = 5500 MHz | | 5.5 | 7.5 | - | dB | Bypass mode |
| Transient time $C_1 = 1 \text{ nF}^{4)6}$ | t _s | - | 0.3 | 3 | μs | High gain- to bypass-mode |
| | | - | 12 | 15 | μs | Bypass- to High gain-mode |
| Transient time $C_1 = 33 \text{ pF}^{4(6)}$ | t _s | - | 0.3 | 3 | μs | High gain- to bypass-mode |
| | | - | 1 | 3 | μs | Bypass- to High gain-mode |
| Inband input 1dB-compression | <i>IP</i> _{1dB} | -22 | -18 | - | dBm | High gain mode |
| point, <i>f</i> = 5500 MHz ³⁾ | | -8 | -4 | - | dBm | Bypass mode |
| Inband input 3 rd -order | IIP ₃ | -16 | -11 | - | dBm | High gain mode $C_1 = 1$ nF |
| intercept point ³⁾⁵⁾ f ₁ = 5500 MHz, f ₂ = f ₁ +/- 1 MHz | | -1 | 4 | - | dBm | Bypass mode $C_1 = 1 \text{ nF}$ |
| Phase discontinuity between ON- and bypass-mode ³⁾ | | -6 | - | 6 | o | Part to part variation after compensation in Base Banc with constant value |
| Stability ⁶⁾ | k | > 1 | - | - | | f = 20 MHz 10 GHz |

1) Based on the application described in chapter 4

2) PCB losses are subtracted

3) Verification based on AQL; not 100% tested in production

4) To be within 1 dB of the final gain

5) Input power HG = -30 dBm for each tone; input power BP = -10 dBm for each tone

6) Guaranteed by device design; not tested in production

Data Sheet



Electrical Characteristics

Table 5Electrical Characteristics1)

 $T_{\rm A} = 25 \text{ °C}, V_{\rm CC} = 2.8 \text{ V}, V_{\rm GPIOX,ON} = 2.8 \text{ V}, V_{\rm GPIOX,OFF} = 0 \text{ V}, f = 4000 - 6000 \text{ MHz}$

| Parameter | Symbol | Values | | | Unit | Note or Test Condition |
|---|--------------------------------|--------|------|-----------------|------|--|
| | | Min. | Тур. | Max. | | |
| Supply voltage | V _{cc} | 1.6 | 2.8 | 3.1 | V | - |
| Control voltages | V _{GPIOx} | 1.0 | _ | V _{cc} | V | High |
| | | 0 | _ | 0.4 | V | Low |
| Supply current | I _{cc} | - | 4.5 | 5.5 | mA | High gain mode |
| | | - | 85 | 120 | μA | Bypass mode |
| | | - | 0.1 | 2 | μA | OFF-Mode |
| Insertion power gain | S ₂₁ ² | 11.2 | 13.7 | 16.2 | dB | High gain mode |
| f=5500 MHz | | -9.5 | -7.5 | -5.5 | dB | Bypass mode |
| Noise figure ²⁾ | NF | - | 1.6 | 2.5 | dB | High gain mode |
| f = 5500 MHz, $Z_{\rm S}$ = 50 Ω | | - | 7.5 | 9.5 | dB | Bypass mode |
| Input return loss ³⁾ | RL _{IN} | 9 | 13 | - | dB | High gain mode |
| f=5500 MHz | | 7 | 11 | - | dB | Bypass mode |
| Output return loss ³⁾ | RL _{OUT} | 12 | 20 | - | dB | High gain mode |
| f=5500 MHz | | 3 | 4 | - | dB | Bypass mode |
| Reverse isolation ³⁾ | $1/ S_{12} ^2$ | 20 | 28 | - | dB | High gain mode |
| f=5500 MHz | | 5.5 | 7.5 | - | dB | Bypass mode |
| Transient time $C_1 = 1 \text{ nF}^{4(6)}$ | t _s | - | 0.3 | 3 | μs | High gain- to bypass-mode |
| | | - | 7 | 10 | μs | Bypass- to High gain-mode |
| Transient time $C_1 = 33 \text{ pF}^{4(6)}$ | t _s | - | 0.3 | 3 | μs | High gain- to bypass-mode |
| | | - | 0.9 | 3 | μs | Bypass- to High gain-mode |
| Inband input 1dB-compression | <i>IP</i> _{1dB} | -22 | -18 | - | dBm | High gain mode |
| point, <i>f</i> = 5500 MHz ³⁾ | | -8 | -4 | - | dBm | Bypass mode |
| Inband input 3 rd -order | IIP ₃ | -15 | -10 | - | dBm | High gain mode $C_1 = 1$ nF |
| intercept point ³⁾⁵⁾ f ₁ = 5500 MHz, f ₂ = f ₁ +/- 1 MHz | | -1 | 4 | - | dBm | Bypass mode $C_1 = 1 \text{ nF}$ |
| Phase discontinuity between ON- and bypass-mode ³⁾ | | -6 | - | 6 | 0 | Part to part variation after compensation in Base Band with constant value |
| Stability ⁶⁾ | k | > 1 | - | - | | f = 20 MHz 10 GHz |

1) Based on the application described in chapter 4

2) PCB losses are subtracted

3) Verification based on AQL; not 100% tested in production

4) To be within 1 dB of the final gain

5) Input power HG = -30 dBm for each tone; input power BP = -10 dBm for each tone

6) Guaranteed by device design; not tested in production



Application Information

1 Application Information

Application Board Configuration

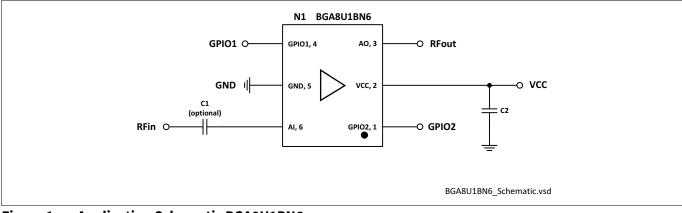




Table 1 Bill of Materials

| Name | Value | Package | Manufacturer | Function |
|---------------|-----------|----------|--------------|-------------------------|
| C1 (optional) | 1nF/33pF | 0402 | Various | DC block ¹⁾ |
| C2 (optional) | ≥1nF | 0402 | Various | RF bypass ²⁾ |
| N1 | BGA8U1BN6 | TSNP-6-2 | Infineon | SiGe LNA |

1) No external DC block is needed if there is pre-filter implemented. DC block capacitor of less or equal than 100 pF is recommended to reduce the switching time during the mode transition.

2) RF bypass recommended to mitigate power supply noise

A list of all application notes is available at http://www.infineon.com/ltelna



Package Information

1 Package Information

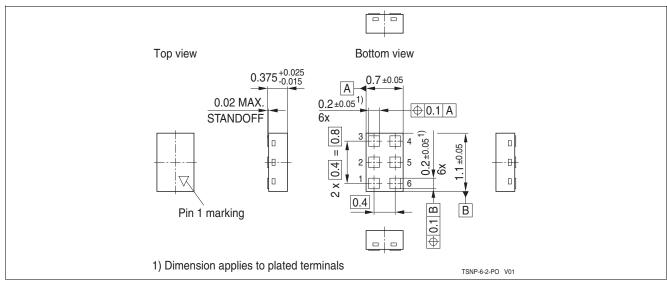


Figure 1 TSNP-6-2 Package Outline (top, side and bottom views)

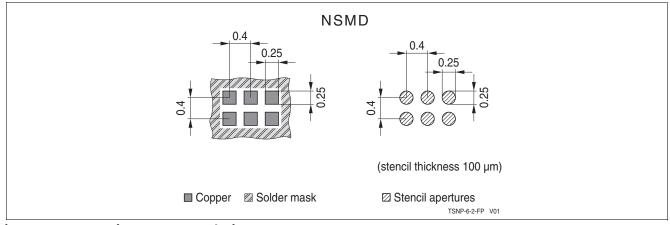


Figure 2 Footprint Recommendation TSNP-6-2

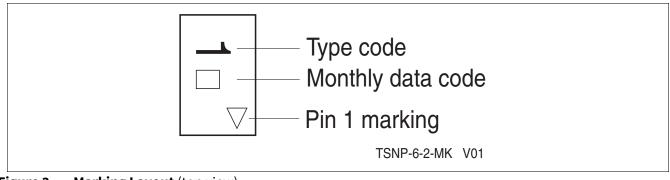
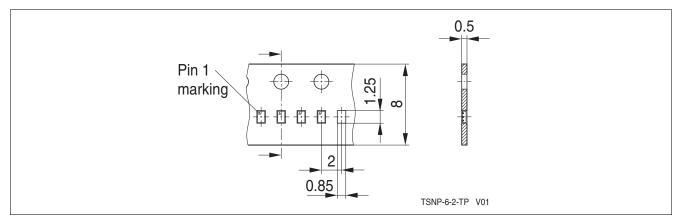


Figure 3Marking Layout (top view)

BGA8U1BN6 Low Noise Amplifier for Ultra High Band 4-6GHz (f.e. LTE - U/ LAA with bypass)

Package Information









| Revision History | | | | | | |
|------------------|--|--|--|--|--|--|
| Page or Item | Subjects (major changes since previous revision) | | | | | |
| Revision 3.2, 2 | 021-04-19 | | | | | |
| 6 | Add Electrical Characterisation for Vcc=1.8V | | | | | |
| 7 | Update Transient Time Information | | | | | |
| 8 | Update Application Information | | | | | |

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